

<b>Search Notes</b>  	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10786554	TAKEHARA, SHINTARO
Examiner	Art Unit	
HENOK G HEYI	2627	

### SEARCHED

Class	Subclass	Date	Examiner

### SEARCH NOTES

Search Notes	Date	Examiner
Searched EAST and referred to previous examiner's notes.	03/19/2008	Henok Heyi
Search updated and consulted Primary Tan Dinh.	10/21/2008	Henok Heyi

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
369	44.35 (text search only - see search history)	10/21/2008	Henok Heyi
369	44.36 (text search only - see search history)	10/21/2008	Henok Heyi
369	275.4 (text search only - see search history)	10/21/2008	Henok Heyi

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